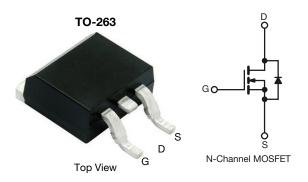


N-Channel 200 V (D-S) 175 °C MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	200			
$R_{DS(on)}$ Typ. (Ω) at V_{GS} = 10 V	0.0076			
${\sf R}_{\sf DS(on)}$ Typ. (Ω) at V _{GS} = 7.5 V	0.0086			
Q _g typ. (nC)	58			
I _D (A)	100			
Configuration	Single			



FEATURES

- ThunderFET® power MOSFET
- Maximum 175 °C junction temperature
- 100 % R_g and UIS tested

APPLICATIONS

- Power supplies:
 - Uninterruptible power supplies
 - AC/DC switch-mode power supplies
 - Lighting
- Synchronous rectification
- DC/DC converter
- Motor drive switch
- DC/AC inverter
- Solar micro inverter
- Class D audio amplifier

ABSOLUTE MAXIMUM RATINGS ($T_A = 25 \text{ °C}$, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	200	N	
Gate-source voltage		V _{GS}	± 20	V	
Continuous drain current	T _C = 25 °C		100		
	T _C = 125 °C	- I _D	62		
Pulsed drain current (t = 100 µs)		I _{DM}	300	A	
Continuous source-drain diode current		ا _S	100		
Single pulse avalanche current ^a		I _{AS}	60		
Single pulse avalanche energy ^a	L = 0.1 mH	E _{AS}	180	mJ	
Maximum power dissipation	T _C = 25 °C		375 ^b	24/	
	T _C = 125 °C	P _D	125 ^b	W	
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +175		
Soldering recommendations (peak temperature) ^c		1	260		

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	MAXIMUM	UNIT	
Maximum junction-to-ambient (PCB mount) ^c		R _{thJA}	40	°C/W	
Maximum junction-to-case (drain)	Steady state	R _{thJC}	0.4	0/10	

Notes

a. Duty cycle ≤ 1 %.

b. See SOA curve for voltage derating.

c. When mounted on 1" square PCB (FR4 material).

d. Package limited.



SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)								
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT		
Static				•	•			
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 V, I_D = 250 \mu A$	200	-	-	V		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	2	-	4	V		
Gate-source leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$	-	-	250	nA		
Zero gate voltage drain current	I _{DSS}	$V_{DS} = 200 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1			
		V _{DS} = 200 V, V _{GS} = 0 V, T _J = 125 °C	-	-	150	μA		
		V _{DS} = 200 V, V _{GS} = 0 V, T _J = 175 °C	-	-	5	mA		
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 10 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	60	-	-	А		
Drain-source on-state resistance ^a	P	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 40 \text{ A}$	-	0.0076	-			
	R _{DS(on)}	$V_{GS} = 7.5 \text{ V}, \text{ I}_{D} = 40 \text{ A}$	-	0.0086	-	Ω		
Forward transconductance a	g _{fs}	V _{DS} = 15 V, I _D = 40 A	-	63	-	S		
Dynamic ^b				•	•			
Input capacitance	Ciss		-	3120	-	pF		
Output capacitance	C _{oss}	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	280	-			
Reverse transfer capacitance	C _{rss}		-	24	-			
Total gate charge	Qg		-	58	87	nC		
Gate-source charge	Q _{gs}	$V_{DS} = 100 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 60 \text{ A}$	-	17.6	-			
Gate-drain charge	Q _{gd}		-	17.2	-			
Output charge	Q _{oss}	$V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	108	162			
Gate resistance	Rg	f = 1 MHz	1.5	3	5	Ω		
Turn-on delay time	t _{d(on)}		-	14	28	ns		
Rise time	tr	$\label{eq:VDD} \begin{array}{l} V_{DD} = 100 \; V, \; R_{L} = 1.66 \; \Omega, \; I_{D} \cong 60 \; A, \\ V_{GEN} = 10 \; V, \; R_{g} = 1 \; \Omega \end{array}$	-	125	250			
Turn-off delay time	t _{d(off)}		-	27	54			
Fall time	t _f		-	80	150			
Drain-Source Body Diode Characteristi	cs			•	•			
Pulse diode forward current (t = 100 μ s)	I _{SM}		-	-	240	А		
Body diode voltage	V _{SD}	$I_F = 30 \text{ A}, V_{GS} = 0 \text{ V}$	-	0.85	1.5	V		
Body diode reverse recovery time	t _{rr}		-	150	300	ns		
Body diode reverse recovery charge	Q _{rr}		-	0.9	1.8	nC		
Reverse recovery fall time	t _a	I _F = 30 A, dl/dt = 100 A/µs	-	125	-	ns		
Reverse recovery rise time	t _b		-	25	-			
Body diode peak reverse recovery charge	I _{RM(REC)}		-	11.5	20	А		

Notes

a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%.$

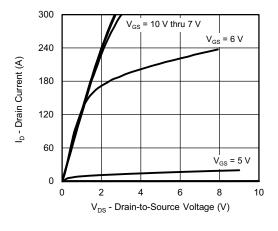
b. Guaranteed by design, not subject to production testing.

c. Independent of operating temperature.

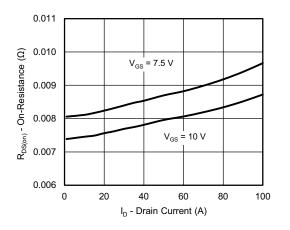
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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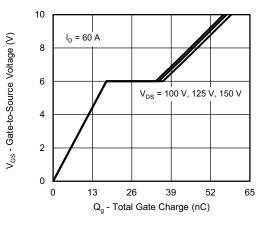




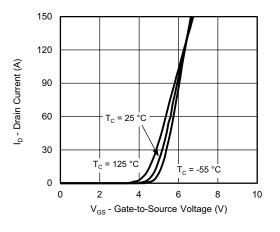
Output Characteristics



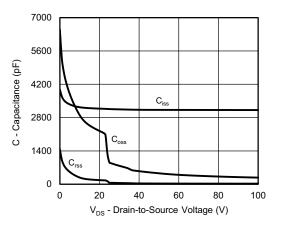
On-Resistance vs. Drain Current and Gate Voltage



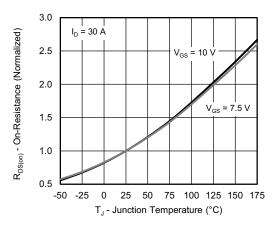
Gate Charge



Transfer Characteristics

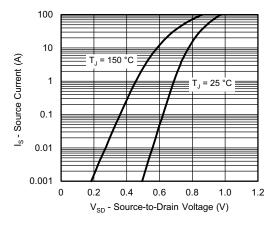


Capacitance

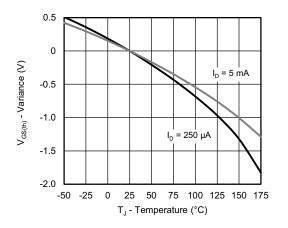


On-Resistance vs. Junction Temperature

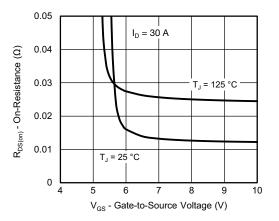




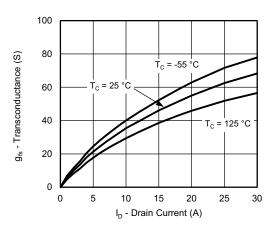
Source-Drain Diode Forward Voltage



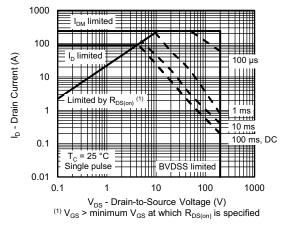
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

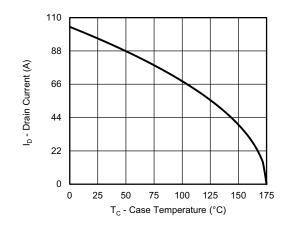


Transconductance

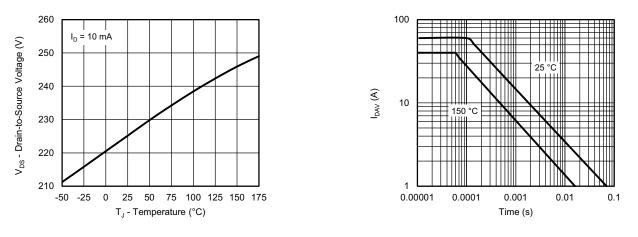


Safe Operating Area, Junction-to-Ambient





Current Derating ^a



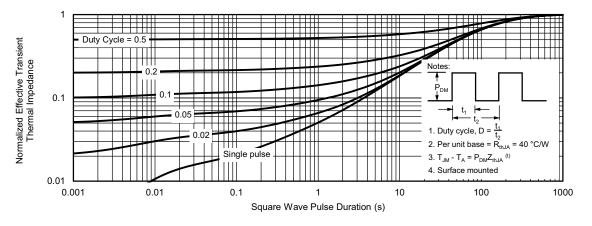
Drain Source Breakdown vs. Junction Temperature

I_{DAV} vs. Time

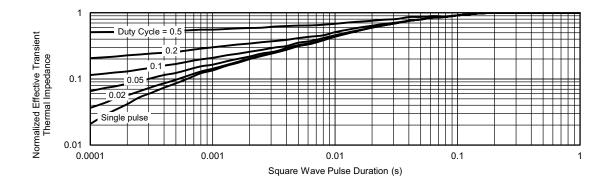
Note

a. The power dissipation P_D is based on T_J max. = 25 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



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